

Notice of References Cited	Application/Control No. 10/523,251	Applicant(s)/Patent Under Reexamination SCHLUCKWERDER ET AL.	
	Examiner John A. Hevey	Art Unit 1709	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,821,142 A	04-1989	Ushifusa et al.	361/739
*	B	US-5,242,867 A	09-1993	Lin et al.	501/32
*	C	US-6,514,890 B1	02-2003	Nagata et al.	501/4
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	11-292616	10-1999	Japan	Shindo Ayako et al.	C04B 35/16
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.